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# **Radiation Tolerant Digital and Analog Circuits and Systems**

Guest Editors:

Message from the Guest Editors

Prof. Dr. Li Chen

Dear Colleagues,

Prof. Dr. Haibin Wang

Dr. Liang Wang

Dr. Kai Xi

Dr. Rui Chen

Deadline for manuscript submissions:

closed (20 September 2023)

The main aim of this Special Issue is to seek high-quality submissions that highlight emerging applications of radiation-tolerant systems, address recent breakthroughs in modeling radiation effects in advanced electronic devices and circuits, present designs of radiation-hardened digital, analog, mixed-signal, and RF integrated circuits, and radiation hardness testing methodologies. The topics of interest include, but are not limited to:

- Basic mechanisms of radiation effects in electronic devices:
- Compact modeling of radiation effects and circuit/layout level optimization (TID and SEE);
- Radiation effects in power devices/circuits:
- Design of radiation-hardened integrated circuits (analog/RF/mixed-signal/digital);
- Radiation hardening and fault tolerance in FPGAs;
- Radiation hardness assurance testing.











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## **Editor-in-Chief**

#### Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

# **Message from the Editor-in-Chief**

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